

**Notice of References Cited**

Application/Control No.

10/033,891

Applicant(s)/Patent Under  
Reexamination  
YEN ET AL.

Examiner

Peter B. Kim

Art Unit

2851

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,703,675	12-1997	Hirukawa et al.	355/53
	B	US-2003/0103196	06-2003	Hirukawa, Shigeru	355/55
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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